

MOS FIELD EFFECT TRANSISTOR

2SJ600

SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SJ600 is P-channel MOS Field Effect Transistor designed for solenoid, motor and lamp driver.

FEATURES

· Low on-state resistance:

- Low Ciss: Ciss = 1900 pF TYP.
- Built-in gate protection diode
- TO-251/TO-252 package

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SJ600	TO-251		
2SJ600-Z	TO-252		

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

$R_{DS(on)1} = 50 \text{ m}\Omega$ MAX. (Vgs = -10 V, ID	= -13 A)			
$R_{DS(on)2} = 79 \text{ m}\Omega$ MAX. (Vgs = -4.0 V, ID	= -13 A			4
• Low Ciss: Ciss = 1900 pF TYP.				m.cn
 Built-in gate protection diode 			35.	30
 TO-251/TO-252 package 		40	37	-0.
		132		Us.
ABSOLUTE MAXIMUM RATINGS (TA	a = 25°C)		CO	
Drain to Source Voltage (Vgs = 0 V)	VDSS	– 60	V	
Gate to Source Voltage (Vps = 0 V)	Vgss	∓20	V	
Drain Current (DC) (Tc = 25°C)	ID(DC)	∓25	Α	
Drain Current (pulse) Note1	ID(pulse)	∓70	Α	
Total Power Dissipation (Tc = 25°C)	Рт	45	W	
Total Power Dissipation (T _A = 25°C)	PT	1.0	W	
Channel Temperature	Tch	150	°C	
Storage Temperature	T _{stg}	-55 to +150	°C	
Single Avalanche Current Note2	IAS	-25	Α	
Single Avalanche Energy Note2	Eas	62.5	mJ	

(TO-251)



(TO-252)



Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, R_G = 25 Ω , V_{GS} = -20 V \rightarrow 0 V

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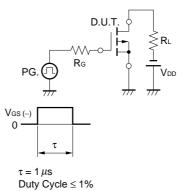
ELECTRICAL CHARACTERISTICS (TA = 25°C)

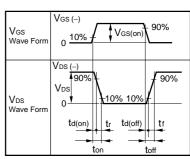
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -60 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	V _{GS} = + 20 V, V _{DS} = 0 V			Ŧ10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = -10 V, I _D = -13 A	10	20		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = -10 V, ID = -13 A		41	50	mΩ
	RDS(on)2	Vgs = -4.0 V, ID = -13 A		55	79	mΩ
Input Capacitance	Ciss	$V_{DS} = -10 V$,		1900		pF
Output Capacitance	Coss	V _G S = 0 V,		350		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		140		pF
Turn-on Delay Time	td(on)	ID = -13 A,		9		ns
Rise Time	t r	$V_{GS(on)} = -10 V$,		10		ns
Turn-off Delay Time	td(off)	$V_{DD} = -30 \text{ V},$ $R_G = 0 \Omega$ $I_D = -25 \text{ A},$ $V_{DD} = -48 \text{ V},$ $V_{GS} = -10 \text{ V}$		67		ns
Fall Time	tf	$R_G = 0 \Omega$	0	19		ns
Total Gate Charge	Q _G	I _D = -25 A,		38		nC
Gate to Source Charge	Qgs	V _{DD} = -48 V,		7		nC
Gate to Drain Charge	QGD	Vcs = -10 V		10		nC
Body Diode Forward Voltage	VF(S-D)	IF = -25 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	1F = -25 A, VGS = 0 V		49		ns
Reverse Recovery Charge	Qrr	di/dt = -100 A/μs		100		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

$V_{GS} = -20 \text{ V} \rightarrow 0 \text{ V}_{m}$ V_{DD} V_{DD}

TEST CIRCUIT 2 SWITCHING TIME



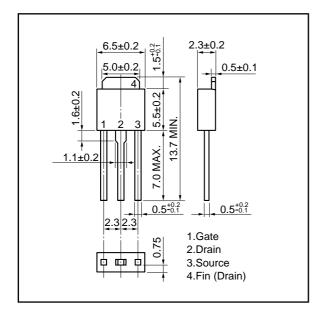


TEST CIRCUIT 3 GATE CHARGE

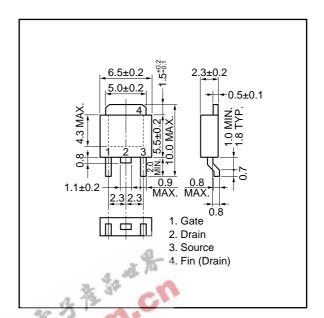
$$\begin{array}{c|c} D.U.T. & \\ \hline \\ I_G = -2 \text{ mA} \\ \hline \\ PG. & \\ \hline \\ \end{array} \begin{array}{c} R_L \\ \hline \\ V_{DD} \\ \hline \end{array}$$

PACKAGE DRAWINGS (Unit: mm)

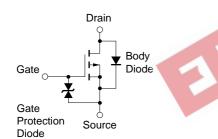
1) TO-251 (MP-3)



2) TO-252 (MP-3Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

NEC 2SJ600

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